Unit: mm

TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type (π -MOSIV)

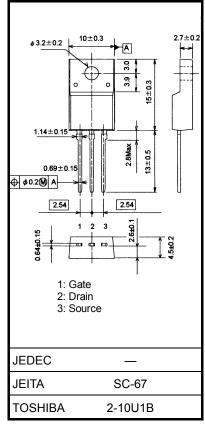
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Switching Regulator Applications

- Low drain-source ON resistance: RDS (ON) = 2.2 Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 3.5 \text{ S}$ (typ.)
- Low leakage current: $I_{DSS} = 100 \ \mu A (V_{DS} = 720 \text{ V})$
- Enhancement model: $V_{th} = 4.0 \sim 5.0 \text{ V} (V_{DS} = 10 \text{ V}, \text{ID} = 1 \text{ mA})$

Unit Characteristic Symbol Rating Drain-source voltage 900 ۷ VDSS 900 v Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$) VDGR V Gate-source voltage ±30 VGSS DC 5 (Note 1) I_D Drain current Α Pulse (t = 1 ms) 15 IDP (Note 1) Drain power dissipation (Tc = 25°C) 45 w P_D Single pulse avalanche energy E_{AS} 595 mJ (Note 2) 5 Avalanche current А I_{AR} 4.5 Repetitive avalanche energy (Note 3) E_{AR} mJ °C Channel temperature T_{ch} 150 °C Storage temperature range Tstg -55~150





Weight: 1.7 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

Thermal Characteristics

| Characteristic | Symbol | Max | Unit | |
|--|------------------------|------|------|--|
| Thermal resistance, channel to case | R _{th (ch-c)} | 2.78 | °C/W | |
| Thermal resistance, channel to ambient | R _{th (ch-a)} | 62.5 | °C/W | |

Note 1: Ensure that the channel temperature does not exceed 150°C during use of the device.

Note 2: $V_{DD} = 90 \text{ V}, \text{ T}_{ch} = 25^{\circ}\text{C}$ (initial), L = 43.6 mH, I_{AR} = 5.0 A, R_G = 25 Ω

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Handle with care.

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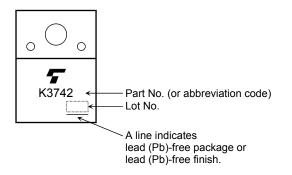
Electrical Characteristics (Ta = 25°C)

| Cha | racteristic | Symbol | Test Condition | Min | Тур. | Max | Unit |
|-------------------------------|----------------|----------------------|---|-----|------|-----|------|
| Gate leakage cu | rrent | I _{GSS} | $V_{GS}=\pm 30~V,~V_{DS}=0~V$ | _ | _ | ±10 | μA |
| Gate-source breakdown voltage | | V (BR) GSS | $I_G=\pm 10 \ \mu\text{A}, \ V_{DS}=0 \ V$ | ±30 | | _ | V |
| Drain cutoff curre | ent | I _{DSS} | $V_{DS} = 720 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$ | | | 100 | μA |
| Drain-source bre | akdown voltage | V (BR) DSS | $I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$ | 900 | | _ | V |
| Gate threshold v | oltage | V _{th} | $V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$ | 4.0 | | 5.0 | V |
| Drain-source ON | resistance | R _{DS (ON)} | $V_{GS} = 10 \text{ V}, \text{ I}_{D} = 3 \text{ A}$ | | 2.2 | 2.5 | Ω |
| Forward transfer | admittance | Y _{fs} | $V_{DS} = 20 \text{ V}, \text{ I}_{D} = 3 \text{ A}$ | 1.5 | 3.5 | _ | S |
| Input capacitance | | C _{iss} | V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz | | 1150 | | pF |
| Reverse transfer capacitance | | C _{rss} | | | 20 | | |
| Output capacitance | | C _{oss} | | | 110 | | |
| Switching time | Rise time | tr | V_{GS} $0 V$ V_{GS} $0 V$ | | 100 | _ | • ns |
| | Turn-on time | t _{on} | | _ | 140 | _ | |
| | Fall time | t _f | | | 40 | | |
| | Turn-off time | t _{off} | Duty \leq 1%, t _w = 10 μ s | | 130 | | |
| Total gate charge | | Qg | | _ | 25 | _ | |
| Gate-source charge | | Q _{gs} | $V_{DD} \simeq 400 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 5 \text{ A}$ | | 11 | _ | nC |
| Gate-drain charge | | Q _{gd} |] | _ | 14 | _ | |

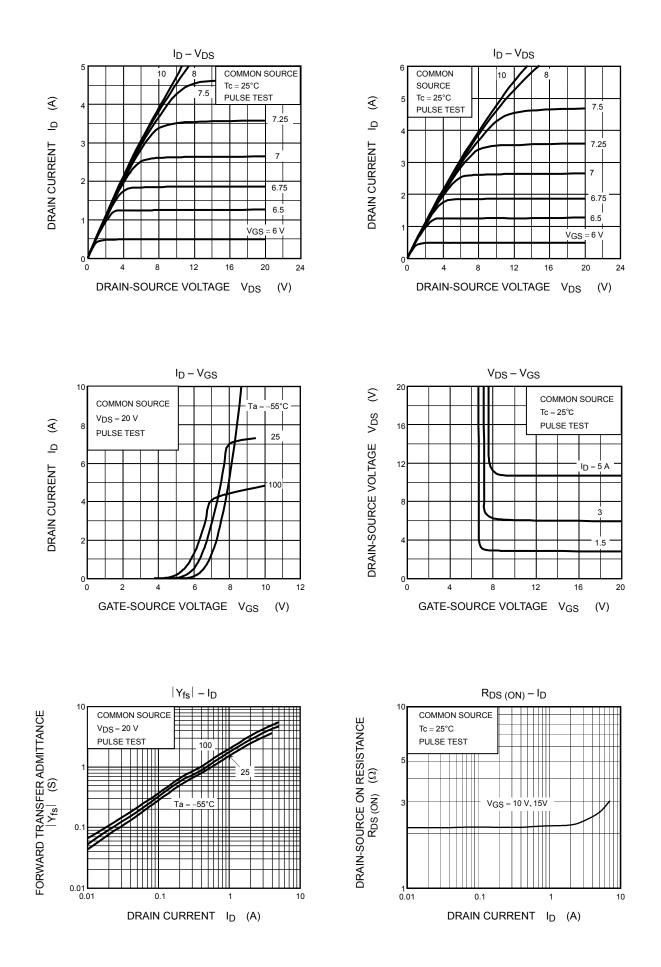
Source-Drain Ratings and Characteristics (Ta = 25°C)

| Characteristic | Symbol | Test Condition | Min | Тур. | Max | Unit |
|--|------------------|---|-----|------|------|------|
| Continuous drain reverse current (Note 1) | I _{DR} | — | _ | _ | 5 | А |
| Pulse drain reverse current (Note 1) | I _{DRP} | — | _ | _ | 15 | А |
| Forward voltage (diode) | V _{DSF} | I _{DR} = 5 A, V _{GS} = 0 V | _ | _ | -1.7 | V |
| Reverse recovery time | t _{rr} | $I_{DR} = 5 \text{ A}, V_{GS} = 0 \text{ V},$ | _ | 900 | _ | ns |
| Reverse recovery charge | Qrr | dl _{DR} /dt = 100 A/μs | _ | 5.4 | _ | μC |

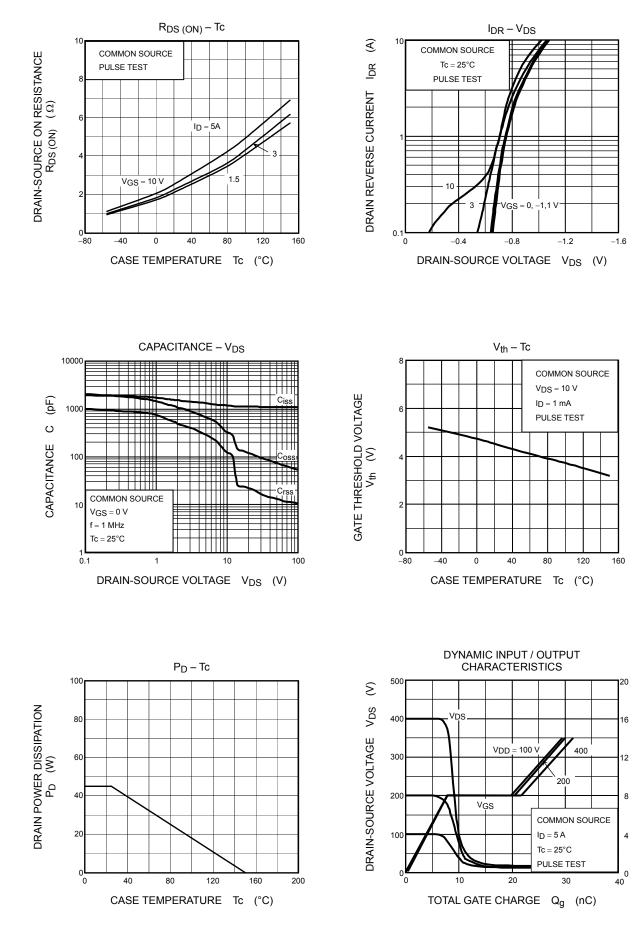
Marking



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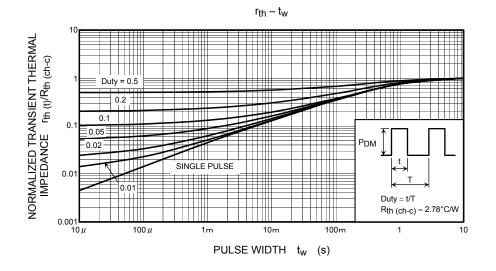
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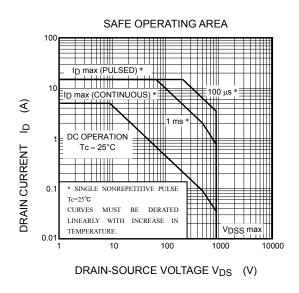


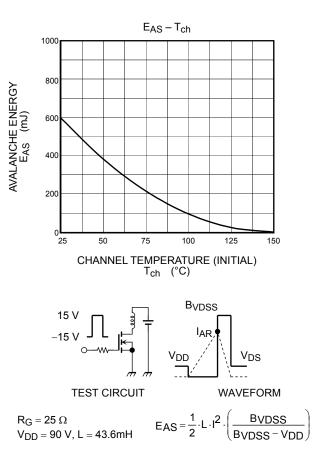
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V_{GS}

GATE-SOURCE VOLTAGE







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